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THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Kusumoto, et al.

Art Unit : 2823

Serial No.: 10/025,322

Examiner: Julio J. Maldonado

Filed

: December 18, 2001

Title

: LASER ANNEALING METHOD AND LASER ANNEALING DEVICE

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

REQUEST FOR INITIALED PTO FORM 1449

Upon reviewing the file, applicants noted that they have not received an initialed copy of the enclosed PTO Form 1449 that accompanied an information disclosure statement filed September 23, 2002 and PTO Form 892s that accompanied an information disclosure statement filed December 18, 2001. For the Examiner's convenience, a new PTO form 1449 that includes the references from the 892s is attached.

Applicants' records show that these information disclosure statements complied with 37 CFR 1.97. Thus, we respectfully request that the examiner initial and return the attached forms as soon as possible. The examiner's prompt attention to this matter would be appreciated.

Respectfully submitted,

Date: 6/9/03

John F. Hayden Reg. No. 37,640

Customer No. 26171

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Fish & Richardson P.C. 1425 K Street, N.W. - 11th Floor Washington, DC 20005-3500 (202) 783-5070 telephone (202) 783-2331 facsimile JFH/adt

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	·				W. David Coleman		2823		
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	A	5,612,250	Mar. 1997	Ohtani et a	<u>. </u>	438	487	AFS ⊠	OTHER
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^{*}A copy of this reference is not being furnished with this Office action. (See Manual of Patent Examining Procedure, Section 707.05(a).)
**APS encompasses any electronic search i.e. text, image, and Commercial Databases.

U.S. Patent and Trademark Office

PTO-892 (Rev. 03-98)

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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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Substitute Form PTO 1449 (Modified) U. Department of Commerce at and Trademark Office	Attorney's Docket No. 07977-076003	Application No. 10/025,322	
Information Disclosure Statement by Applicant	Applicant Kusumoto, et al.		
(Use several sheets if necessary) (37 CFR §1.98(b))	Filing Date December 18, 2001	Group Art Unit 1268	

	<u> </u>		U.S. Pate	ent Documents	·		
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	AA	RE36,371	Nov 2, 1999	Imahashi et al.			
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	Other Documents (include Author, Title, Date, and Place of Publication)							
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Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation next communication to applicant.	if not in conformance and not considered. Include copy of this form with
	Substitute Disclosure Form (PTO-1449)

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Substitute Form PT 1449 (Modified)

U.5 Department of Commerce atent and Trademark Office

Attorney's Docket No. 07977-076003

Application No. 10/025,322

Information Description Statement by Applicant

(Use several sheets if necessary)

Applicant Kusumoto, et al.

Filing Date

December 18, 2001

Group Art Unit 2823

(37 CFR §1.98(b))

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Examiner Signature	Date Considered
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EXAMINER: Initials citation considered. Draw line through citation if no	t in conformance and not considered. Include copy of this form with

next communication to applicant.

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